AMENDMENTS TO THE CLAIMS

The following is a complete listing of the claims, which replace all previous versions and listings of the claims.

- 1-29. (canceled).
- 30. (currently amended) A field emission device, comprising a substrate having a top side and an opposite bottom side;

 [[an]] a conductive epitaxial buffer layer affixed to the top side of the substrate; a dielectric layer disposed on the top side;

a conductive layer disposed on top of the dielectric layer opposite the substrate, the conductive layer and the dielectric layer defining a cavity extending downwardly to the substrate; and

at least one nanorod affixed to the substrate via the <u>conductive</u> epitaxial buffer layer and substantially disposed within the cavity.

- 31. (canceled).
- 32. (original) The field emission device of Claim 30, employed in an imaging system.
- 33. (original) The field emission device of Claim 30, employed in a lighting system.
- 34. (previously presented) The field emission device of Claim 30, wherein the nanorod is an X-nanorod, wherein X comprises a carbide, an oxide, a nitride, an oxynitride, an oxycarbide or a silicide, or combinations thereof.

- 35. (original) The field emission device of Claim 30, wherein the substrate comprises an inorganic monocrystalline substance.
- 36. (previously presented) The field emission device of Claim 35, wherein the inorganic monocrystalline substance comprises silicon, an aluminum oxide, and silicon carbide, and combinations thereof.
- 37. (previously presented) The field emission device of Claim 30, wherein the dielectric layer comprises silicon dioxide, silicon nitride, silicon oxynitride, and aluminum oxide, and combinations thereof.
- 38. (previously presented)A nanostructure, comprising:
 an inorganic substrate having a top side and a bottom side;
 an epitaxial conductive buffer layer disposed adjacent to the top side; and
 a plurality of elongated carburized metal nanostructures extending from the
 epitaxial conductive buffer layer.
- 39. (previously presented) The nanostructure of Claim 38, wherein the inorganic substrate comprises a crystalline substance made of silicon, aluminum oxide, and silicon carbide, or combinations thereof.
- 40. (original) The nanostructure of Claim 38, wherein the plurality of elongated carburized metal nanostructures comprises at least one nanorod.
- 41. (original) The nanostructure of Claim 38, wherein the plurality of elongated carburized metal nanostructures comprises at least one nanoribbon.

- 42. (original) The nanostructure of Claim 38, wherein the plurality of elongated carburized metal nanostructures each has a smaller dimension of less than 800 nm.
- 43. (previously presented) The nanostructure of Claim 38, wherein the carburized metal is carburized from an oxide of a metal comprising molybdenum, niobium, hafnium, silicon, tungsten, titanium, or zirconium, or combinations thereof.
 - 44. (original) A field emission device, comprising a substrate having a top side and an opposite bottom side; a dielectric layer disposed on the top side;
- a conductive layer disposed on top of the dielectric layer opposite the substrate, the conductive layer and the dielectric layer defining a cavity extending downwardly to the substrate;
- a conductive platform, having a top surface, disposed on the top side of the substrate within the cavity; and
- at least one nanorod affixed to the top surface of the conductive platform and substantially disposed within the cavity.
- 45. (original) The field emission device of Claim 44, wherein the conductive platform comprises a conic-shaped member having a relatively large bottom surface opposite the top surface, the bottom surface affixed to the substrate.
- 46. (previously presented) The field emission device of Claim 44, wherein the conductive platform comprises silicon, molybdenum, platinum, palladium, tantalum, or niobium, or combinations thereof.

- 47. (original) The field emission device of Claim 44, wherein the nanorod is a carbide nanorod.
- 48. (original) The field emission device of Claim 44, wherein the substrate comprises an inorganic monocrystalline substance.
- 49. (previously presented) The field emission device of Claim 48, wherein the inorganic monocrystalline substance comprises silicon, aluminum oxide and silicon carbide, or combinations thereof.
- 50. (original) The field emission device of Claim 44, wherein the substrate comprises a polycrystalline material.
- 51. (original) The field emission device of Claim 44, wherein the substrate comprises amorphous glass.
- 52. (original) The field emission device of Claim 44, wherein the dielectric layer comprises silicon dioxide.
 - 53. (canceled).
 - 54. (currently amended) A field emission device, comprising a substrate having a top side and an opposite bottom side;
- a polycrystalline <u>conductive</u> diffusion barrier affixed to the top side of the substrate;
 - a dielectric layer disposed on the top side;

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a conductive layer disposed on top of the dielectric layer opposite the substrate, the conductive layer and the dielectric layer defining a cavity extending downwardly to the substrate; and

at least one nanorod affixed to the substrate via the polycrystalline <u>conductive</u> diffusion barrier and substantially disposed within the cavity.

- 55. (currently amended) A nanostructure, comprising:
- an inorganic substrate having a top side and a bottom side;
- a polycrystalline <u>conductive</u> diffusion barrier disposed adjacent to the top side; and
- a plurality of elongated carburized metal nanostructures extending from the polycrystalline conductive diffusion barrier.